

# International **IR** Rectifier

PD - 95604

## IRG4IBC30FDPbF

### INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

#### Features

- Very Low 1.59V voltage drop
- 2.5kV, 60s insulation voltage ⑤
- 4.8 mm creepage distance to heatsink
- Fast: Optimized for medium operating frequencies ( 1-5 kHz in hard switching, >20 kHz in resonant mode).
- IGBT co-packaged with HEXFRED™ ultrafast, ultrasoft recovery antiparallel diodes
- Tighter parameter distribution
- Industry standard Isolated TO-220 Fullpak™ outline

#### Benefits

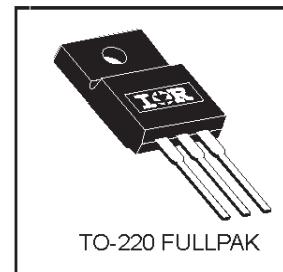
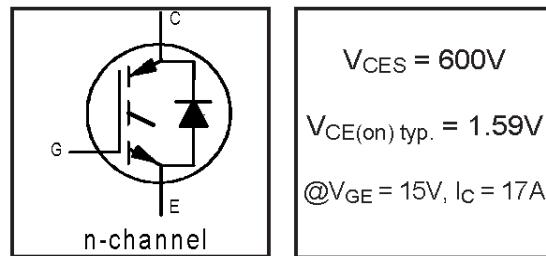
- Simplified assembly
- Highest efficiency and power density
- HEXFRED™ antiparallel Diode minimizes switching losses and EMI
- Lead-Free

#### Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	20.3	
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	11	
$I_{CM}$	Pulsed Collector Current ①	120	A
$I_{LM}$	Clamped Inductive Load Current ②	120	
$I_F @ T_C = 100^\circ C$	Diode Continuous Forward Current	8.5	
$I_{FM}$	Diode Maximum Forward Current	120	
$V_{ISOL}$	RMS Isolation Voltage, Terminal to Case ⑤	2500	V
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	45	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	18	
$T_J$	Operating Junction and	-55 to +150	
$T_{STG}$	Storage Temperature Range		$^\circ C$
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 Screw.	10 lbf-in (1.1 N·m)	

#### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case - IGBT	—	2.8	$^\circ C/W$
$R_{\theta JC}$	Junction-to-Case - Diode	—	4.1	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	65	
Wt	Weight	2.0 (0.07)	—	g (oz)

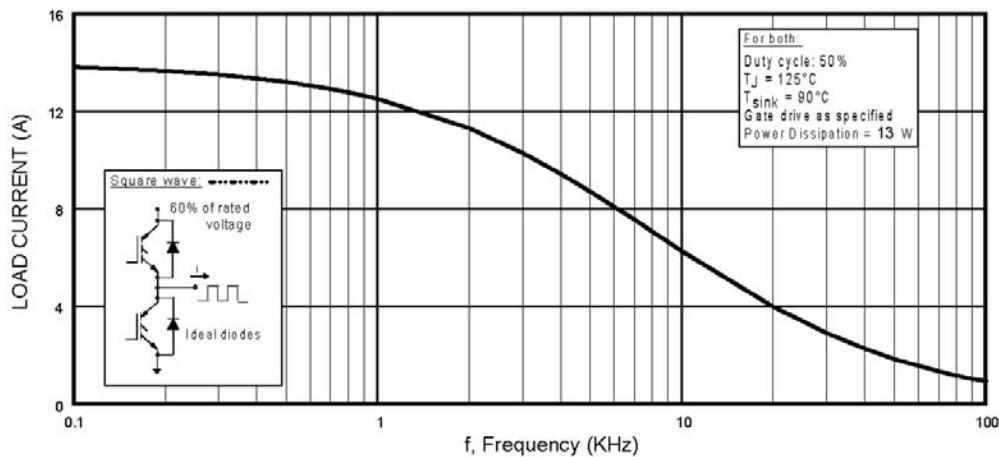


**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

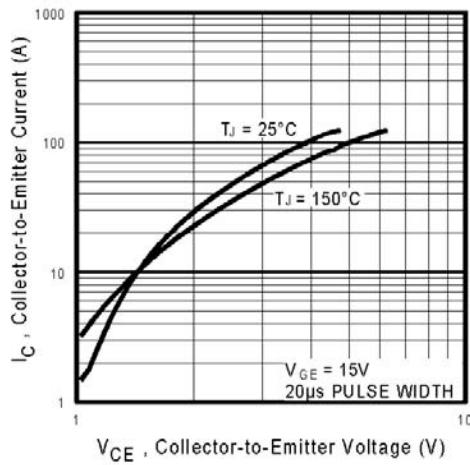
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{CES}}$	Collector-to-Emitter Breakdown Voltage <sup>③</sup>	600	—	—	V	$V_{\text{GE}} = 0\text{V}$ , $I_C = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	—	0.69	—	V/ $^\circ\text{C}$	$V_{\text{GE}} = 0\text{V}$ , $I_C = 1.0\text{mA}$
$V_{\text{CE}(\text{on})}$	Collector-to-Emitter Saturation Voltage	—	1.59	1.8	V	$I_C = 17\text{A}$ $V_{\text{GE}} = 15\text{V}$
		—	1.99	—		$I_C = 31\text{A}$ See Fig. 2, 5
		—	1.70	—		$I_C = 17\text{A}$ , $T_J = 150^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	3.0	—	6.0		$V_{\text{CE}} = V_{\text{GE}}$ , $I_C = 250\mu\text{A}$
$\Delta V_{\text{GE}(\text{th})/\Delta T_J}$	Temperature Coeff. of Threshold Voltage	—	-11	—	mV/ $^\circ\text{C}$	$V_{\text{CE}} = V_{\text{GE}}$ , $I_C = 250\mu\text{A}$
$g_{\text{fe}}$	Forward Transconductance <sup>④</sup>	6.1	10	—	S	$V_{\text{CE}} = 100\text{V}$ , $I_C = 17\text{A}$
$I_{\text{CES}}$	Zero Gate Voltage Collector Current	—	—	250	$\mu\text{A}$	$V_{\text{GE}} = 0\text{V}$ , $V_{\text{CE}} = 600\text{V}$
		—	—	2500		$V_{\text{GE}} = 0\text{V}$ , $V_{\text{CE}} = 600\text{V}$ , $T_J = 150^\circ\text{C}$
$V_{\text{FM}}$	Diode Forward Voltage Drop	—	1.4	1.7	V	$I_C = 12\text{A}$ See Fig. 13
		—	1.3	1.6		$I_C = 12\text{A}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GES}}$	Gate-to-Emitter Leakage Current	—	—	$\pm 100$	nA	$V_{\text{GE}} = \pm 20\text{V}$

**Switching Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

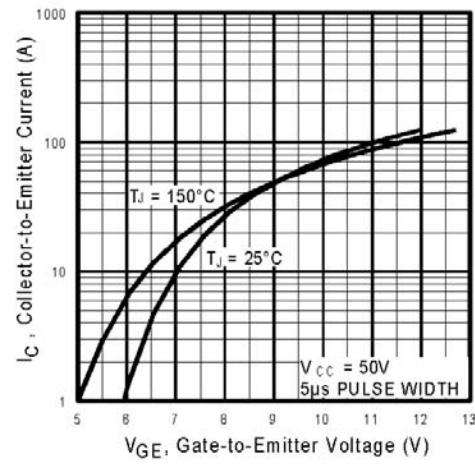
	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge (turn-on)	—	51	77	nC	$I_C = 17\text{A}$
$Q_{\text{ge}}$	Gate - Emitter Charge (turn-on)	—	7.9	12		$V_{\text{CC}} = 400\text{V}$ See Fig. 8
$Q_{\text{gc}}$	Gate - Collector Charge (turn-on)	—	19	28		$V_{\text{GE}} = 15\text{V}$
$t_{d(\text{on})}$	Turn-On Delay Time	—	42	—	ns	$T_J = 25^\circ\text{C}$
$t_r$	Rise Time	—	26	—		$I_C = 17\text{A}$ , $V_{\text{CC}} = 480\text{V}$
$t_{d(\text{off})}$	Turn-Off Delay Time	—	230	350		$V_{\text{GE}} = 15\text{V}$ , $R_G = 23\Omega$
$t_f$	Fall Time	—	160	230	mJ	Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18
$E_{\text{on}}$	Turn-On Switching Loss	—	0.63	—		
$E_{\text{off}}$	Turn-Off Switching Loss	—	1.39	—		
$E_{\text{ts}}$	Total Switching Loss	—	2.02	3.9	mJ	
$t_{d(\text{on})}$	Turn-On Delay Time	—	42	—		$T_J = 150^\circ\text{C}$ , See Fig. 9, 10, 11, 18
$t_r$	Rise Time	—	27	—		$I_C = 17\text{A}$ , $V_{\text{CC}} = 480\text{V}$
$t_{d(\text{off})}$	Turn-Off Delay Time	—	310	—		$V_{\text{GE}} = 15\text{V}$ , $R_G = 23\Omega$
$t_f$	Fall Time	—	310	—	mJ	Energy losses include "tail" and diode reverse recovery.
$E_{\text{ts}}$	Total Switching Loss	—	3.2	—		
$L_E$	Internal Emitter Inductance	—	7.5	—	nH	Measured 5mm from package
$C_{\text{ies}}$	Input Capacitance	—	1100	—	pF	$V_{\text{GE}} = 0\text{V}$
$C_{\text{oes}}$	Output Capacitance	—	74	—		$V_{\text{CC}} = 30\text{V}$ See Fig. 7
$C_{\text{res}}$	Reverse Transfer Capacitance	—	14	—		$f = 1.0\text{MHz}$
$t_{rr}$	Diode Reverse Recovery Time	—	42	60	ns	$T_J = 25^\circ\text{C}$ See Fig.
		—	80	120		$T_J = 125^\circ\text{C}$ 14
$I_{rr}$	Diode Peak Reverse Recovery Current	—	3.5	6.0	A	$T_J = 25^\circ\text{C}$ See Fig.
		—	5.6	10		$T_J = 125^\circ\text{C}$ 15
$Q_{rr}$	Diode Reverse Recovery Charge	—	80	180	nC	$T_J = 25^\circ\text{C}$ See Fig.
		—	220	600		$T_J = 125^\circ\text{C}$ 16
$di_{(\text{rec})M}/dt$	Diode Peak Rate of Fall of Recovery During $t_b$	—	180	—	A/ $\mu\text{s}$	$T_J = 25^\circ\text{C}$ See Fig.
		—	120	—		$T_J = 125^\circ\text{C}$ 17



**Fig. 1** - Typical Load Current vs. Frequency  
 (Load Current =  $I_{RMS}$  of fundamental)



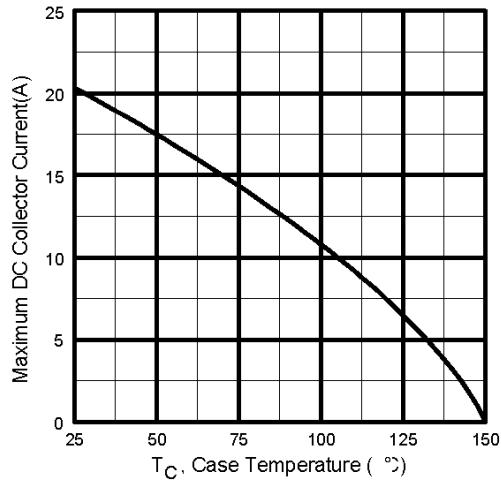
**Fig. 2** - Typical Output Characteristics



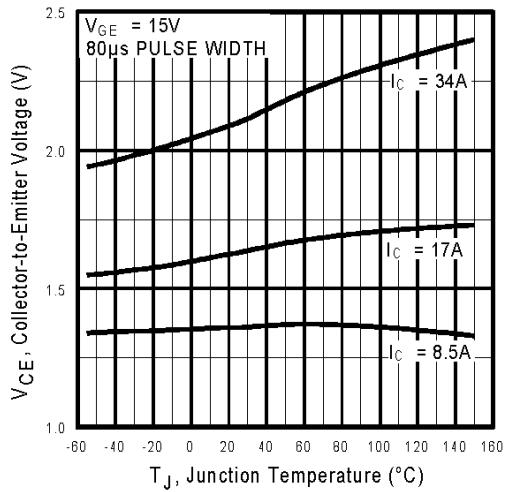
**Fig. 3** - Typical Transfer Characteristics

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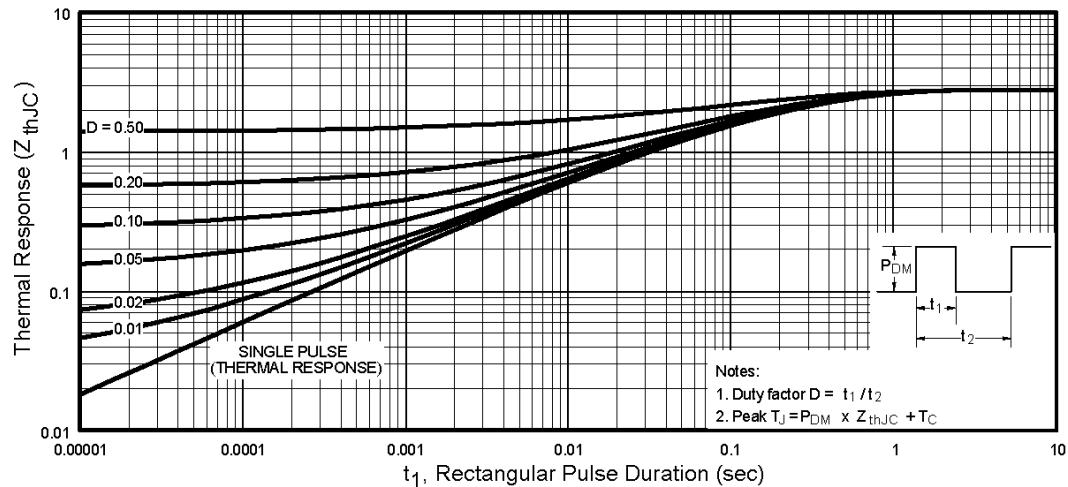
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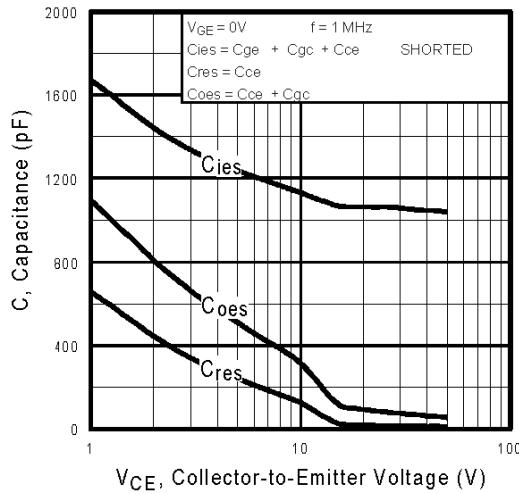
**Fig. 4** - Maximum Collector Current vs. Case Temperature



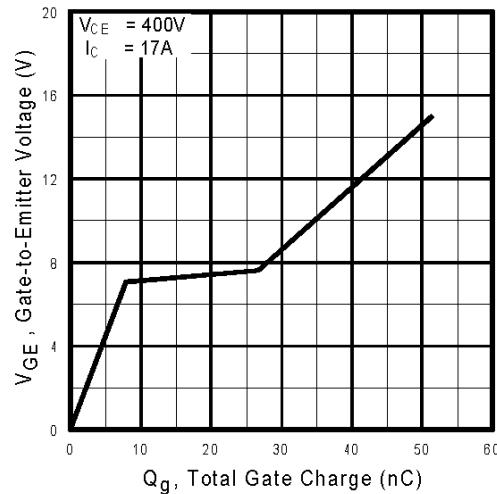
**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature



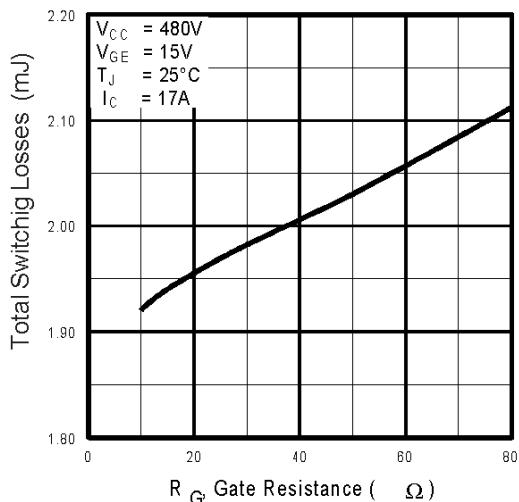
**Fig. 6** - Maximum Effective Transient Thermal Impedance, Junction-to-Case



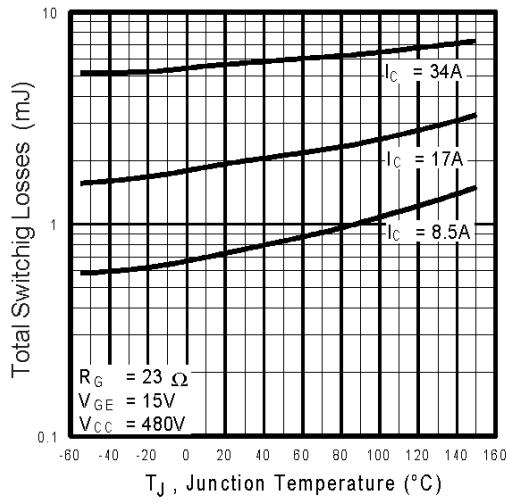
**Fig. 7** - Typical Capacitance vs.  
Collector-to-Emitter Voltage



**Fig. 8** - Typical Gate Charge vs.  
Gate-to-Emitter Voltage



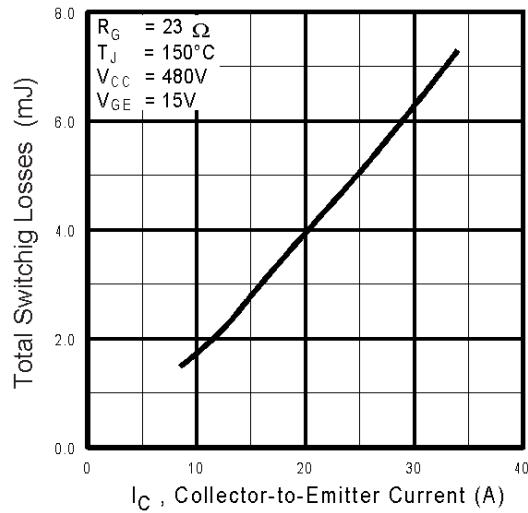
**Fig. 9** - Typical Switching Losses vs. Gate  
Resistance



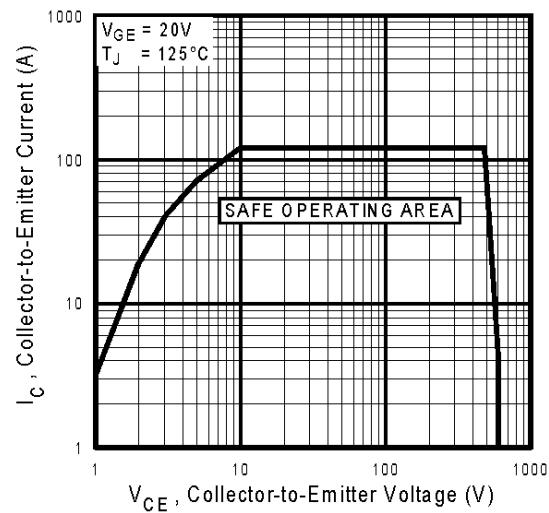
**Fig. 10** - Typical Switching Losses vs.  
Junction Temperature

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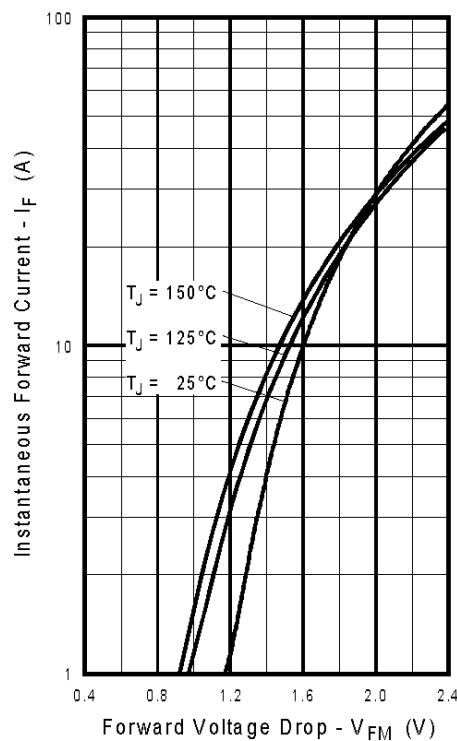
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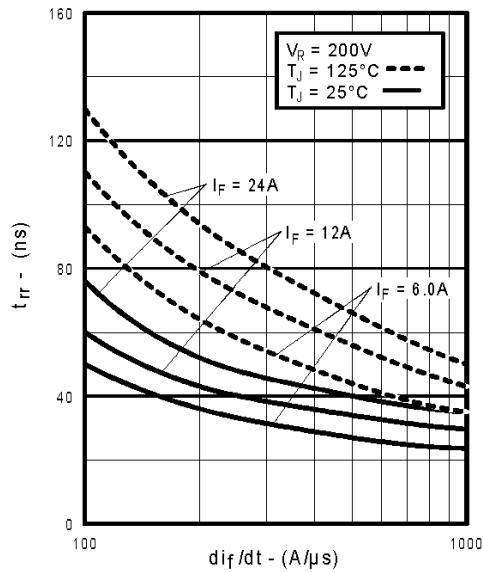
**Fig. 11** - Typical Switching Losses vs.  
Collector-to-Emitter Current



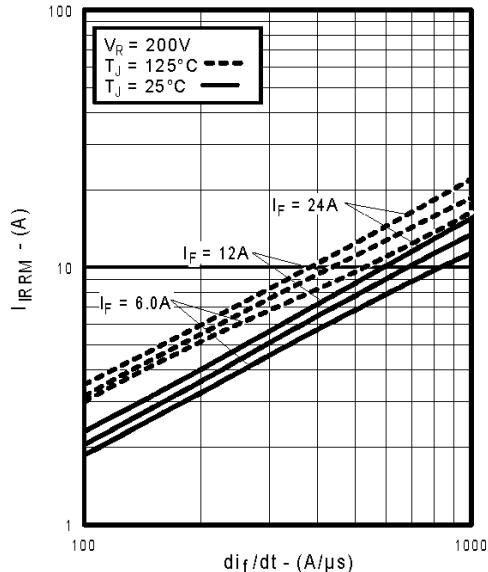
**Fig. 12** - Turn-Off SOA



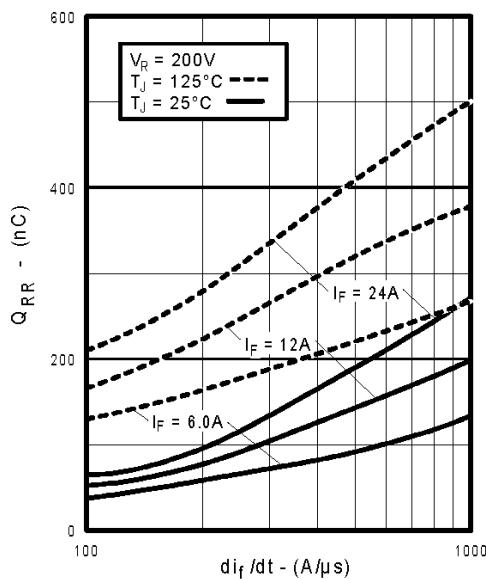
**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current



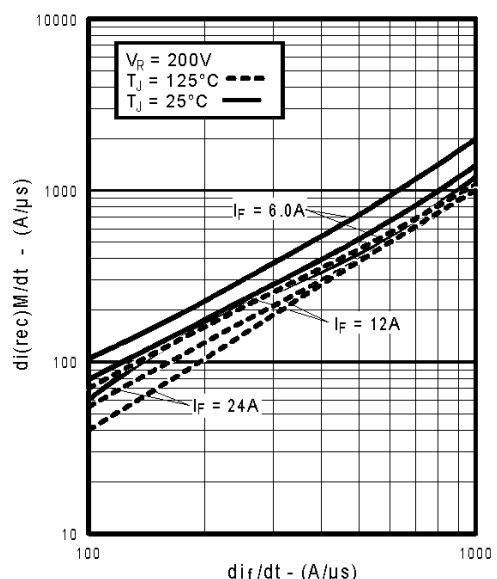
**Fig. 14** - Typical Reverse Recovery vs.  $di_f/dt$



**Fig. 15** - Typical Recovery Current vs.  $di_f/dt$



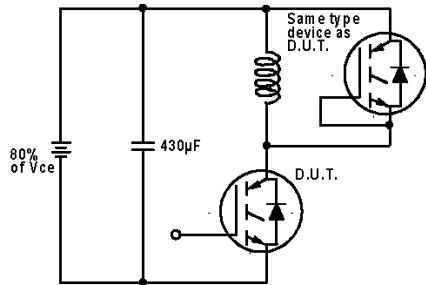
**Fig. 16** - Typical Stored Charge vs.  $di_f/dt$



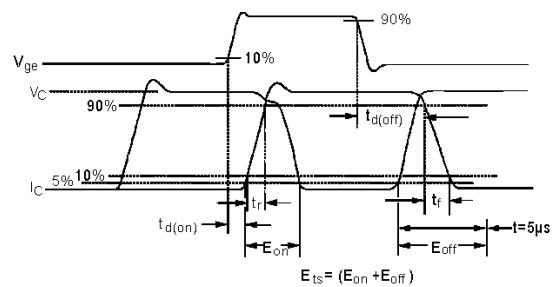
**Fig. 17** - Typical  $di_{(rec)M}/dt$  vs.  $di_f/dt$

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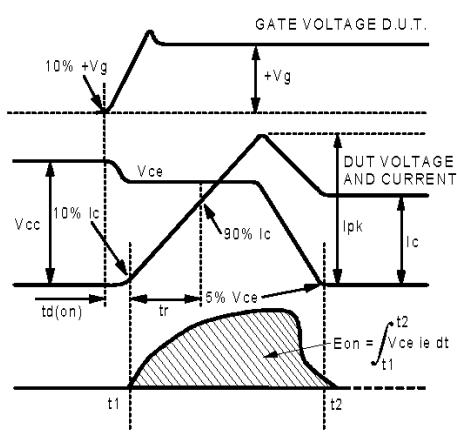
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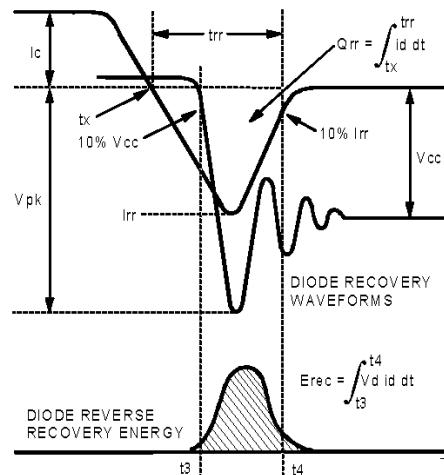
**Fig. 18a** - Test Circuit for Measurement of I<sub>LM</sub>, E<sub>on</sub>, E<sub>off(diode)</sub>, t<sub>rr</sub>, Q<sub>rr</sub>, I<sub>rr</sub>, t<sub>d(on)</sub>, t<sub>r</sub>, t<sub>d(off)</sub>, t<sub>f</sub>



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining E<sub>off</sub>, t<sub>d(off)</sub>, t<sub>f</sub>



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining E<sub>on</sub>, t<sub>d(on)</sub>, t<sub>r</sub>



**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining E<sub>rec</sub>, t<sub>rr</sub>, Q<sub>rr</sub>, I<sub>rr</sub>

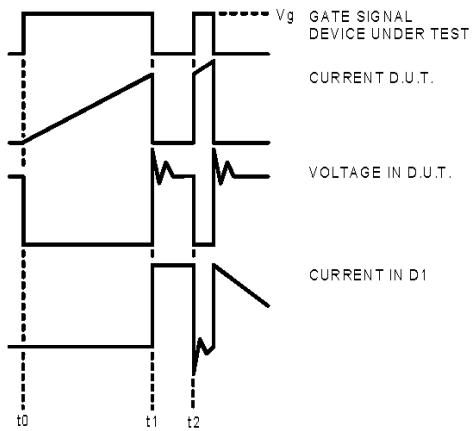


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

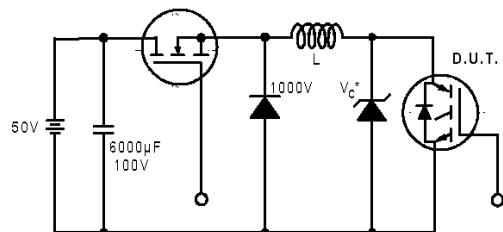


Figure 19. Clamped Inductive Load Test Circuit

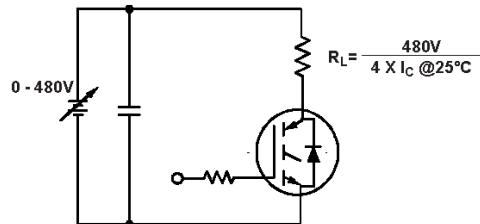


Figure 20. Pulsed Collector Current Test Circuit

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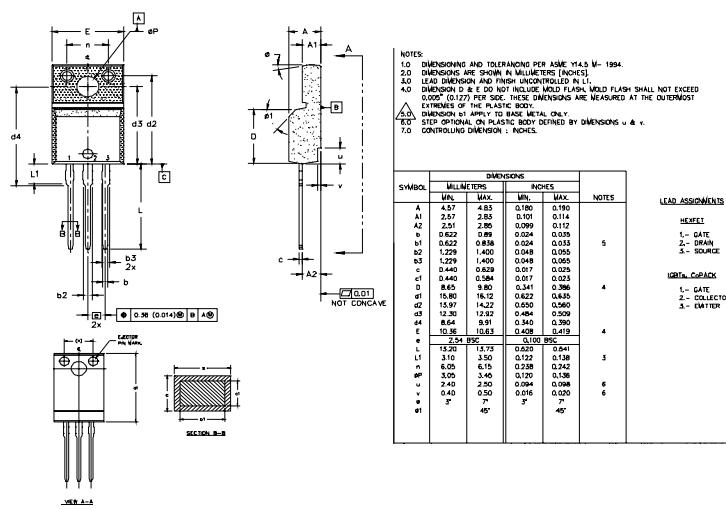
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## Notes:

- ① Repetitive rating:  $V_{GE}=20V$ ; pulse width limited by maximum junction temperature (figure 20)
- ②  $V_{CC}=80\% (V_{CES})$ ,  $V_{GE}=20V$ ,  $L=10\mu H$ ,  $R_G = 23\Omega$  (figure 19)
- ③ Pulse width  $\leq 80\mu s$ ; duty factor  $\leq 0.1\%$ .
- ④ Pulse width 5.0 $\mu s$ , single shot.
- ⑤  $t = 60s$ ,  $f = 60Hz$

## TO-220 Full-Pak Package Outline

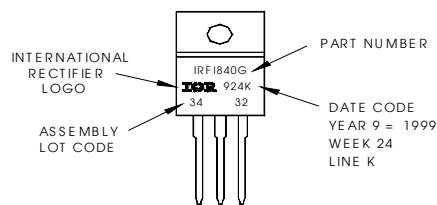
Dimensions are shown in millimeters (inches)



## TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G WITH ASSEMBLY LOT CODE 3432 ASSEMBLED ON WW 24 1999 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.

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